

## Features

- Advanced high cell density Trench technology
- Low  $R_{DS(ON)}$
- High Current Capability
- Green Device Available

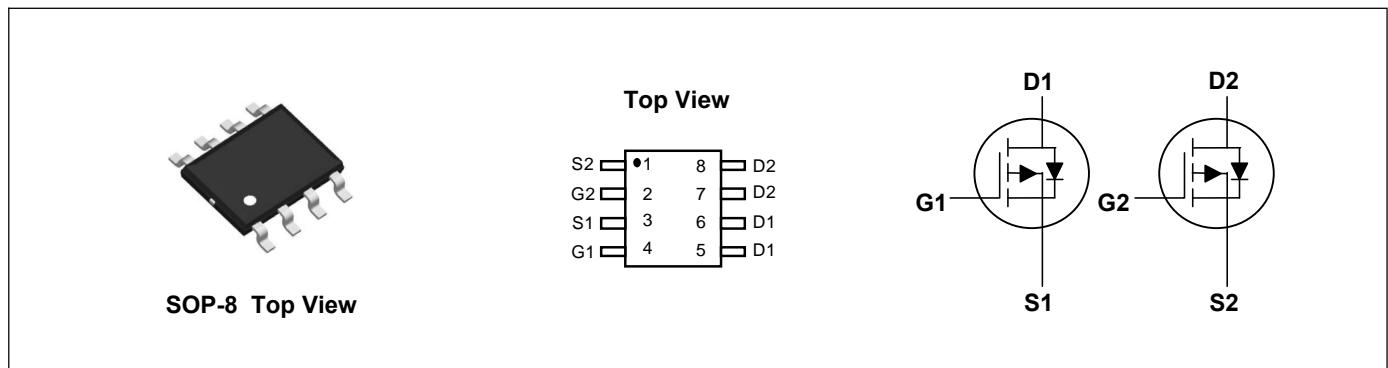
## Product Summary



$V_{DS}$	-30	V
$I_D$	-7.6	A
$R_{DS(ON)}$ (at $V_{GS}=-10V$ )	55	mΩ
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$ )	65	mΩ

## Applications

- High Frequency Point-of-Load, Synchronous Buck Converter for MB/NB/UMPC/VGA
- Battery Protection Charge/Discharge
- Load Switch



## Absolute Maximum Ratings( $T_A=25^\circ C$ , unless otherwise noted)

Parameter	Symbol	Rating	Units
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D @ T_A=25^\circ C$	-7.6	A
Continuous Drain Current	$I_D @ T_A=70^\circ C$	-6.1	A
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	-38	A
Total Power Dissipation <sup>3</sup>	$P_D @ T_A=25^\circ C$	2	W
Total Power Dissipation <sup>3</sup>	$P_D @ T_A=70^\circ C$	1.28	W
Storage Temperature Range	$T_{STG}$	-55 to 150	°C
Operating Junction Temperature Range	$T_J$	-55 to 150	°C

## Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance Junction-Ambient <sup>1</sup> ( $t \leq 10s$ )	$R_{\theta JA}$	48	62.5	°C/W
Thermal Resistance Junction-Ambient <sup>1</sup> (Steady State)		74	90	°C/W
Thermal Resistance Junction-Lead(Steady State)	$R_{\theta JL}$	32	40	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}$ , $I_D=-250\mu\text{A}$	-30	---	---	V
Static Drain-Source On-Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=-10\text{V}$ , $I_D=-7.6\text{A}$	---	45.5	55	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}$ , $I_D=-7\text{A}$	---	57.5	65	$\text{m}\Omega$
		$V_{\text{GS}}=-2.5\text{V}$ , $I_D=-6\text{A}$	---	75	85	$\text{m}\Omega$
		$V_{\text{GS}}=V_{\text{DS}}$ , $I_D = -250\mu\text{A}$	-0.6	-0.9	-1.5	V
On state drain current	$I_{\text{D(ON)}}$	$V_{\text{GS}}=-10\text{V}$ , $V_{\text{DS}}=-5\text{V}$	-38	---	---	A
Drain-Source Leakage Current	$I_{\text{DSS}}$	$V_{\text{DS}}=-20\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=25^\circ\text{C}$	---	---	-1	$\mu\text{A}$
		$V_{\text{DS}}=-20\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=55^\circ\text{C}$	---	---	-5	$\mu\text{A}$
Gate-Source Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm20\text{V}$ , $V_{\text{DS}}=0\text{V}$	---	---	$\pm100$	nA
Forward Transconductance	$g_{\text{fs}}$	$V_{\text{DS}}=-5\text{V}$ , $I_D=-7.6\text{A}$	---	25	---	S
Gate Resistance	$R_g$	$V_{\text{DS}}=0\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	0.8	1.7	2.6	$\Omega$
Total Gate Charge (10V)	$Q_g$	$V_{\text{DS}}=-15\text{V}$ , $V_{\text{GS}}=-10\text{V}$ , $I_D=-7.6\text{A}$	---	12.5	---	nC
Total Gate Charge (4.5V)	$Q_g$		---	6	---	
Gate-Source Charge	$Q_{\text{gs}}$		---	1	---	
Gate-Drain Charge	$Q_{\text{gd}}$		---	2	---	
Turn-On Delay Time	$T_{\text{d(on)}}$	$V_{\text{DS}}=-15\text{V}$ , $V_{\text{GS}}=-10\text{V}$ , $R_L=1.3\Omega$ , $R_G=3\Omega$	---	3	---	ns
Rise Time	$T_r$		---	7.5	---	
Turn-Off Delay Time	$T_{\text{d(off)}}$		---	20	---	
Fall Time	$T_f$		---	6	---	
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=-15\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	---	525	630	pF
Output Capacitance	$C_{\text{oss}}$		---	95	125	
Reverse Transfer Capacitance	$C_{\text{rss}}$		---	75	105	

**Drain-Source Diode Characteristics**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Continuous Source Current <sup>1,4</sup>	$I_s$	$V_G=V_D=0\text{V}$ , Force Current	---	---	-2.5	A
Diode Forward Voltage <sup>2</sup>	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}$ , $I_s=-1\text{A}$ , $T_J=25^\circ\text{C}$	---	-0.7	-1	V
Reverse Recovery Time	$t_{\text{rr}}$	$I_F=-7.6\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$ , $T_J=25^\circ\text{C}$	---	14	---	nS
	$Q_{\text{rr}}$		---	6	---	nC

**Note:**

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$
- 3.The power dissipation is limited by 150°C junction temperature
- 4.The data is theoretically the same as  $I_D$  and  $I_{\text{DM}}$  , in real applications , should be limited by total power dissipation.

## Typical Characteristics

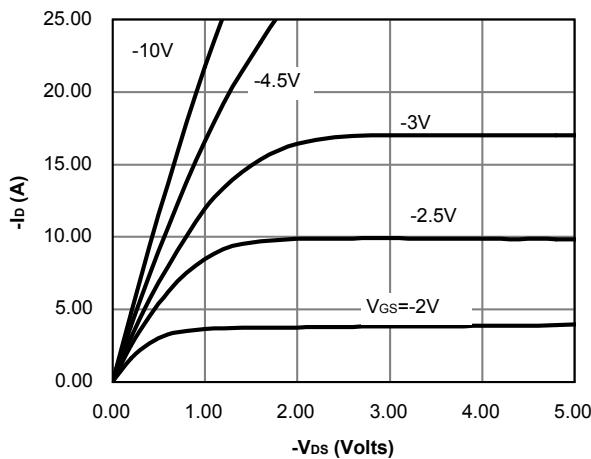


Fig 1: On-Region Characteristics

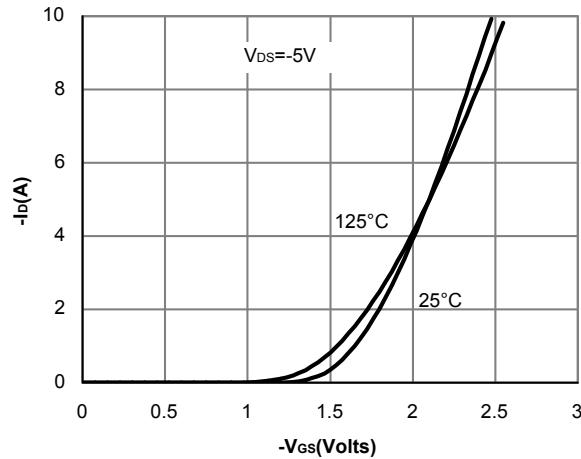


Figure 2: Transfer Characteristics

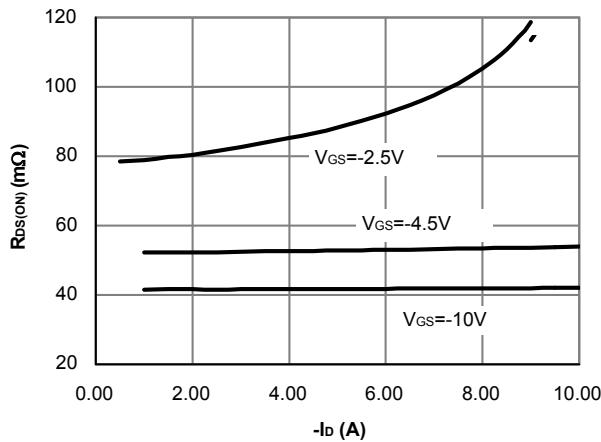


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

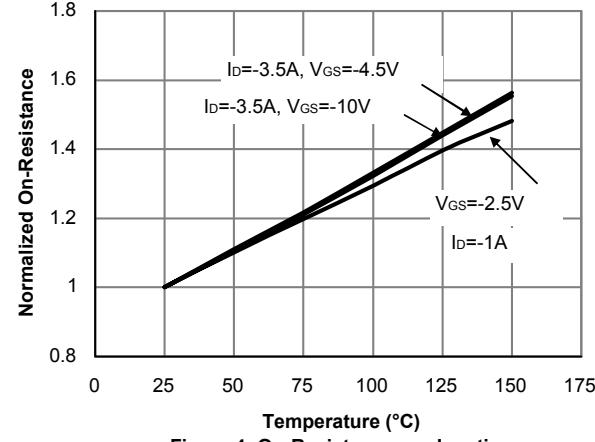


Figure 4: On-Resistance vs. Junction Temperature

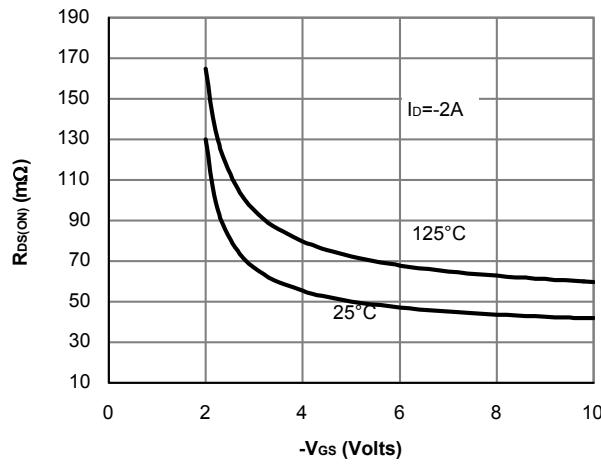


Figure 5: On-Resistance vs. Gate-Source Voltage

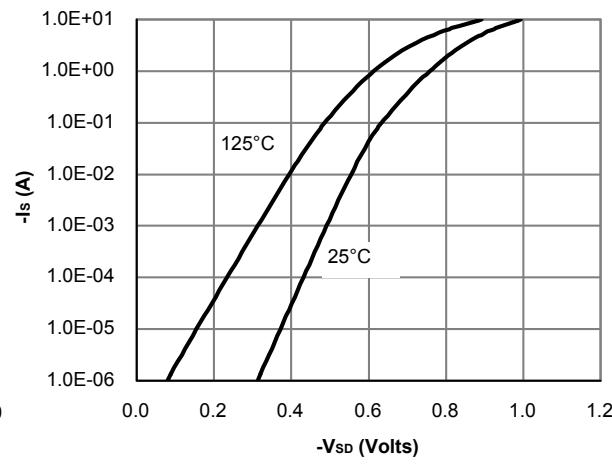
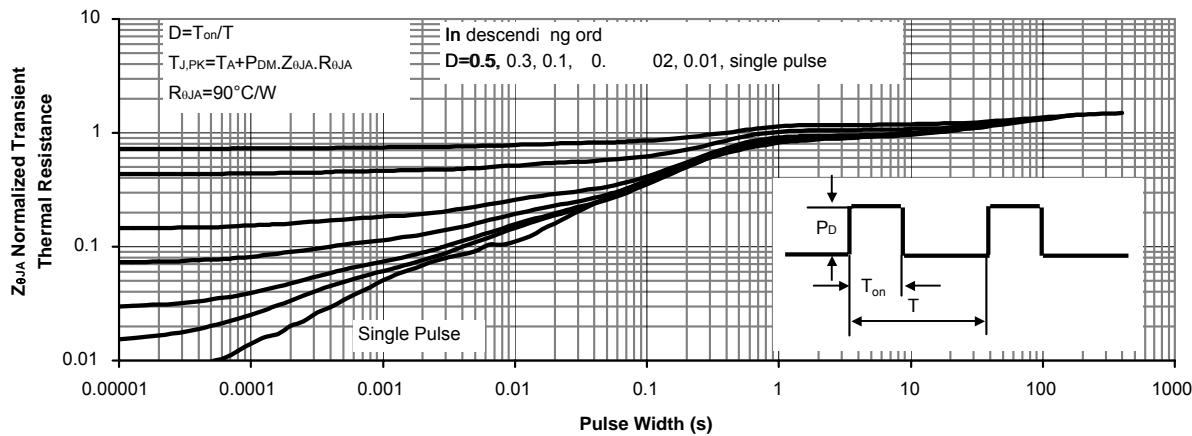
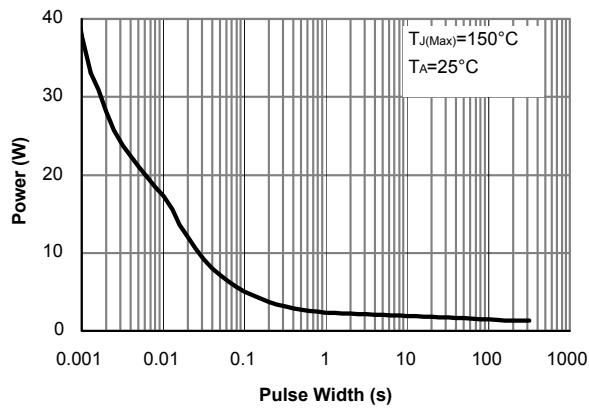
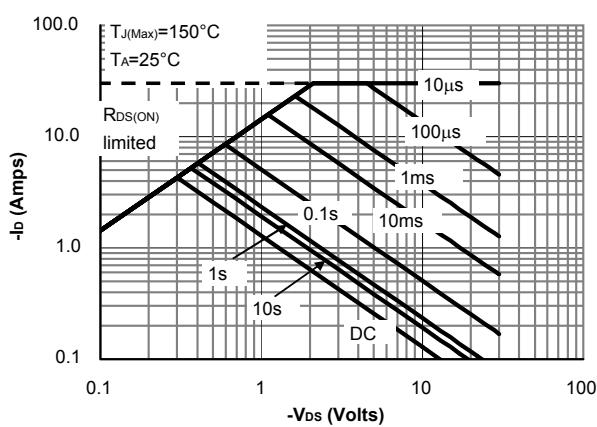
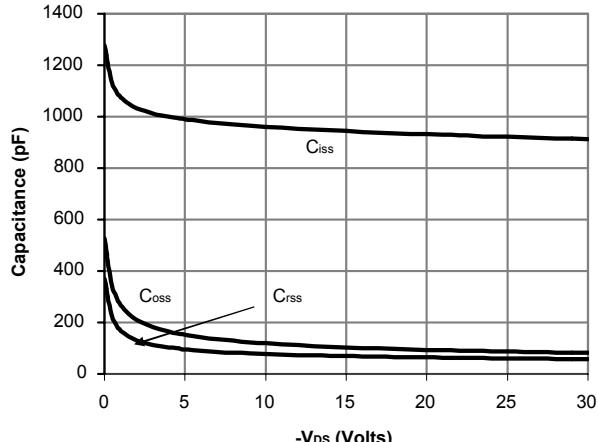
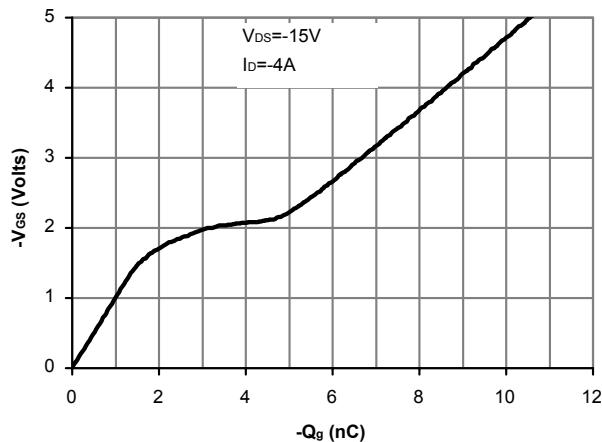
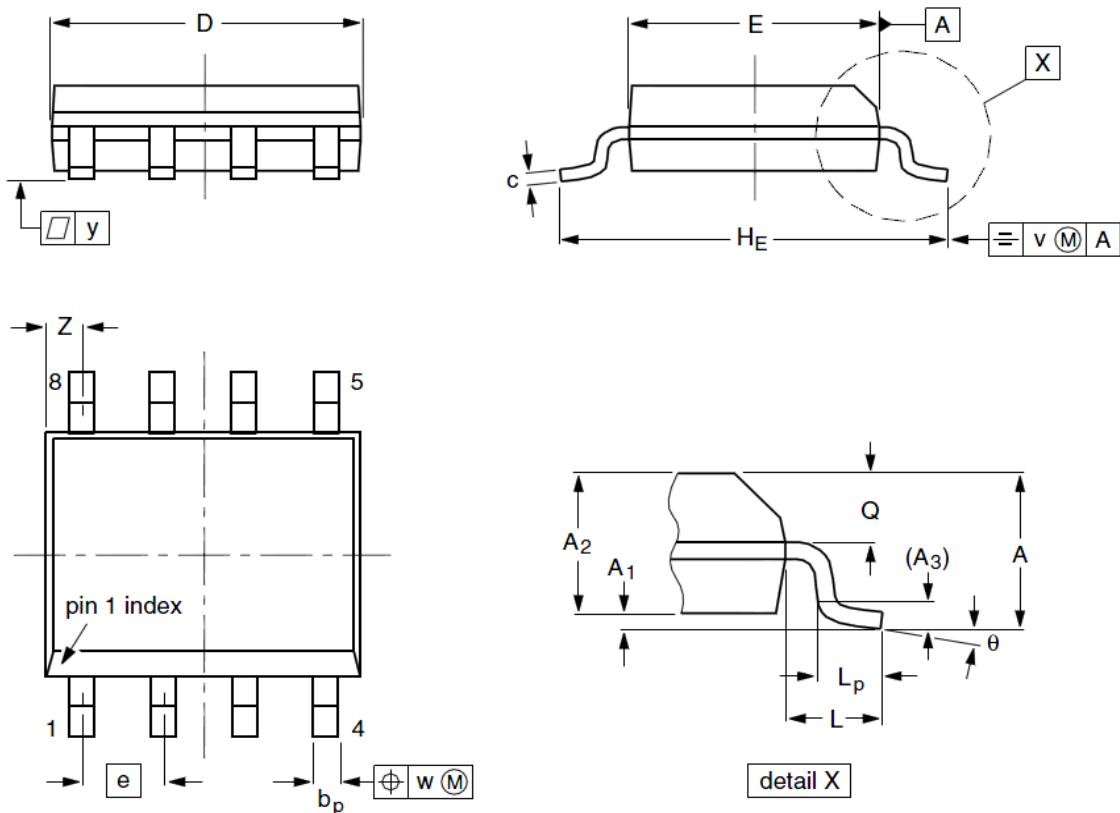


Figure 6: Body-Diode Characteristics



### SOP-8 Package Outline Dimensions



<b>Symbol</b>	<b>Dimensions (unit:mm)</b>			<b>Symbol</b>	<b>Dimensions (unit:mm)</b>		
	<b>Min</b>	<b>Typ</b>	<b>Max</b>		<b>Min</b>	<b>Typ</b>	<b>Max</b>
<b>A</b>	1.35	1.55	1.75	<b>A<sub>1</sub></b>	0.10	0.18	0.25
<b>A<sub>2</sub></b>	1.25	1.45	1.65	<b>A<sub>3</sub></b>	--	0.25	--
<b>b<sub>p</sub></b>	0.36	0.42	0.51	<b>c</b>	0.19	0.22	0.25
<b>D</b>	4.70	4.92	5.10	<b>E</b>	3.80	3.90	4.00
<b>e</b>	--	1.27	--	<b>H<sub>E</sub></b>	5.80	6.00	6.20
<b>L</b>	--	1.05	--	<b>L<sub>P</sub></b>	0.40	0.68	1.00
<b>Q</b>	0.60	0.65	0.73	<b>v</b>	--	0.25	--
<b>w</b>	--	0.25	--	<b>y</b>	--	0.10	--
<b>Z</b>	0.30	0.50	0.70	<b>θ</b>	0°		8°